Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/813,907	ZHANG ET AL.
Examiner	Art Unit
Alain L. Bashore	1762

Alain L. Bashore

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
previous search updated	11/13/20	05 AB	
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